

INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(PTO-1449)

 ATTY. DOCKET NO.
62807-037

SERIAL NO.

 APPLICANT
Shinji ITO, et al.

 FILING DATE
February 14, 2002

GROUP

 bc979 U.S. PTO
 10/074239

02/14/02

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
<i>6</i>	5,940,591	8/17/1999	Boyle et al.			

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

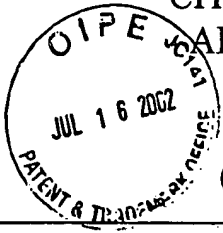
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U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
<i>HB</i>	8-204701	8/9/1996	Japan (w/ English Abstract)				
<i>HB</i>	11-149385	6/2/1999	Japan (w/ English Abstract)				
<i>HB</i>	11-85546	3/30/1999	Japan (w/ English Abstract)				

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>B</i>	"Department of Defense Trusted Computer System Evaluation Criteria", DOD, 5200.28-STD, December 26, 1985, pp. 1-116.

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SHEET 1 OF 1

INFORMATION DISCLOSURE
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APPLICATION

(PTO-1449)

ATTY. DOCKET NO.
062807-0037SERIAL NO.
10/074,239APPLICANT
Shinji ITOH, et al.FILING DATE
February 14, 2002GROUP
2131

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US 5,577,209	11/19/1996	Boyle et al.	
		US 5,680,452	10/21/1997	Shanton	
		US 6,772,419 B1	08/03/2004	Sekiguchi et al.	
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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number &-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No
		WO 00/10278	02/24/2000	CRYPTIK SECURE COMMUNICATIONS, LLC.		X	
		EP 0 743 777 A2	11/20/1996	SUN MICROSYSTEMS, INC.		X	
		JP 11-149385	06/02/1999	HITACHI LTD.		JAPAN (w/ENGLISH ABSTRACT)	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

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